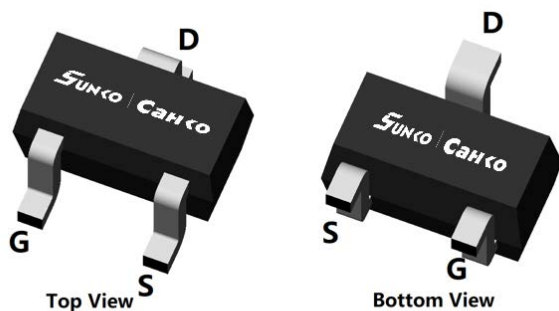
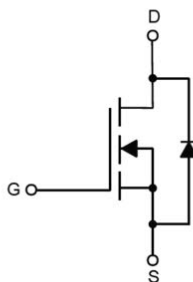


N-Channel Enhancement Mode Field Effect Transistor



SOT-523



Product Summary

• V_{DS}	50V
• I_D	300mA
• $R_{DS(ON)}$ (at $V_{GS}=10V$)	<1100mΩ
• $R_{DS(ON)}$ (at $V_{GS}=4.5V$)	<1200mΩ

General Description

- Trench Power MV MOSFET technology
- Voltage controlled small signal switch
- Low input Capacitance
- Fast Switching Speed
- Low Input / Output Leakage
- Moisture Sensitivity Level 1
- Epoxy Meets UL 94 V-0 Flammability Rating
- Halogen Free

Applications

- Battery operated systems
- Solid-state relays
- Direct logic-level interface: TTL/CMOS

■ Absolute Maximum Ratings ($T_A=25^{\circ}\text{C}$ unless otherwise noted)

Parameter		Symbol	Limit	Unit
Drain-source Voltage		V_{DS}	50	V
Gate-source Voltage		V_{GS}	± 20	V
Drain Current	$T_A=25^{\circ}\text{C}$	I_D	300	mA
	$T_A=100^{\circ}\text{C}$		189	
Pulsed Drain Current ^A		I_{DM}	2	A
Total Power Dissipation ^B	$T_A=25^{\circ}\text{C}$	P_D	290	mW
	$T_A=100^{\circ}\text{C}$		116	
Junction and Storage Temperature Range		T_J, T_{STG}	-55~+150	$^{\circ}\text{C}$

■ Thermal resistance

Parameter		Symbol	Typ	Max	Units
Thermal Resistance Junction-to-Ambient ^C	Steady-State	$R_{\theta JA}$	360	430	$^{\circ}\text{C/W}$

■ Ordering Information (Example)

PREFERED P/N	PACKING CODE	Marking	MINIMUM PACKAGE(pcs)	INNER BOX QUANTITY(pcs)	OUTER CARTON QUANTITY(pcs)	DELIVERY MODE
BSS138BE	F2	138	3000	30000	120000	7" reel

■ Electrical Characteristics (T_J=25°C unless otherwise noted)

Parameter	Symbol	Conditions	Min	Typ	Max	Units
Static Parameter						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} = 0V, I _D =250μA	50	-	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =50V, V _{GS} =0V	-	-	1	μA
		V _{DS} =50V, V _{GS} =0V, T _j =150°C	-	-	100	
Gate-Body Leakage Current	I _{GSS}	V _{GS} = ±20V, V _{DS} =0V	-	-	±100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D =250μA	0.8	1.2	1.6	V
Static Drain-Source On-Resistance	R _{DS(on)}	V _{GS} =10V, I _D =300mA	-	670	1100	mΩ
		V _{GS} =4.5V, I _D =200mA	-	730	1200	
Diode Forward Voltage	V _{SD}	I _S =300mA, V _{GS} =0V	-	-	1.2	V
Gate resistance	R _G	f=1MHz	-	8	-	Ω
Maximum Body-Diode Continuous Current	I _S		-	-	300	mA
Dynamic Parameters						
Input Capacitance	C _{iss}	V _{DS} =25V, V _{GS} =0V, f=1MHz	-	39	-	pF
Output Capacitance	C _{oss}		-	5.7	-	
Reverse Transfer Capacitance	C _{rss}		-	3.3	-	
Switching Parameters						
Total Gate Charge	Q _g	V _{GS} =10V, V _{DS} =25V, I _D =1A	-	1.8	-	nC
Gate-Source Charge	Q _{gs}		-	0.49	-	
Gate-Drain Charge	Q _{gd}		-	0.26	-	
Reverse Recovery Charge	Q _{rr}	I _F =1A, di/dt=100A/us	-	4	-	nC
Reverse Recovery Time	t _{rr}		-	14	-	ns
Turn-on Delay Time	t _{D(on)}	V _{GS} =10V, V _{DD} =25V, I _D =1A R _{GEN} =3Ω	-	3	-	ns
Turn-on Rise Time	t _r		-	19	-	
Turn-off Delay Time	t _{D(off)}		-	5	-	
Turn-off fall Time	t _f		-	23	-	

A. Repetitive rating; pulse width limited by max. junction temperature.

B. P_d is based on max. junction temperature, using junction-case thermal resistance.

C. The value of R_{θJA} is measured with the device mounted on 1 in² FR-4 board with 2oz. Copper, in the still air environment with T_A =25°C. The maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.

■ Typical Electrical and Thermal Characteristics Diagrams

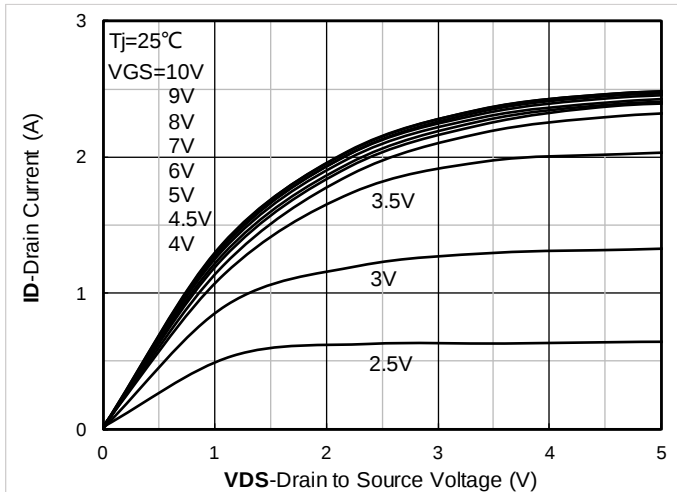


Figure 1. Output Characteristics

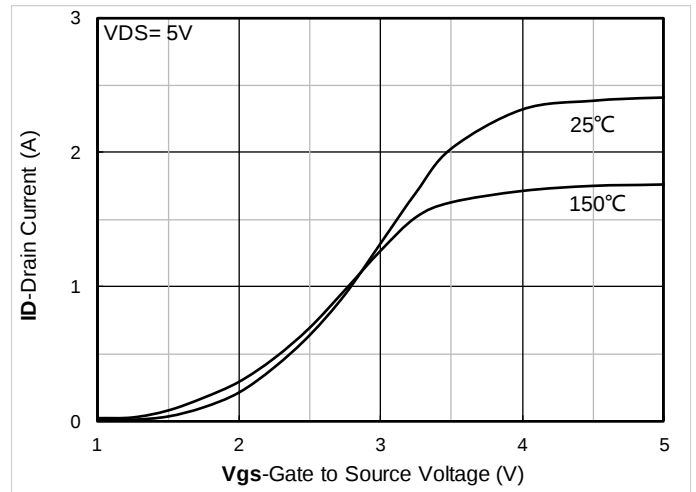


Figure 2. Transfer Characteristics

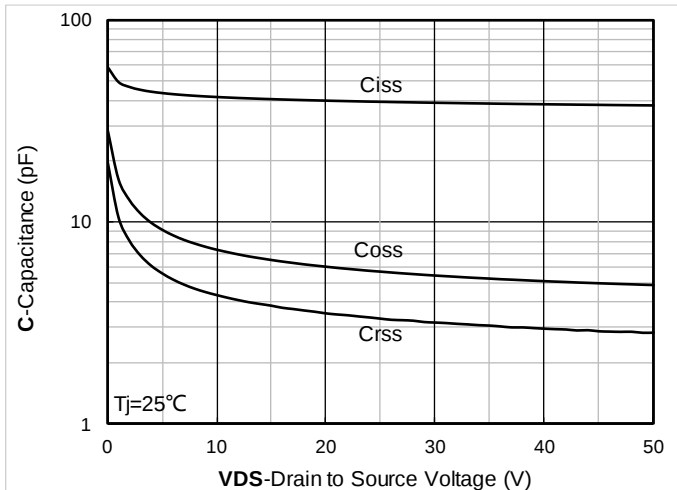


Figure 3. Capacitance Characteristics

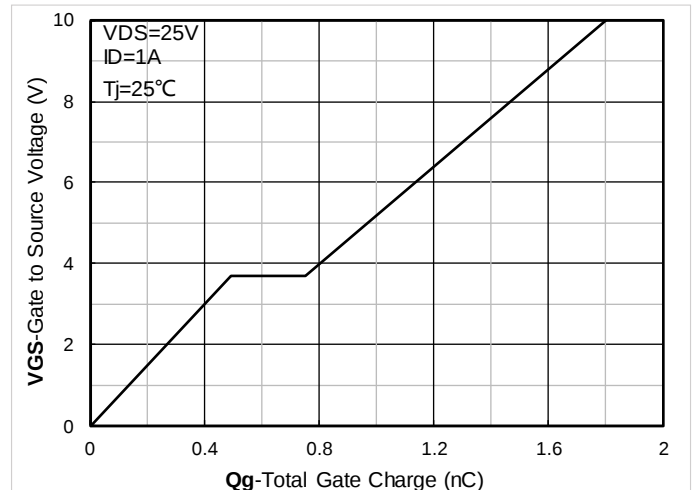


Figure 4. Gate Charge

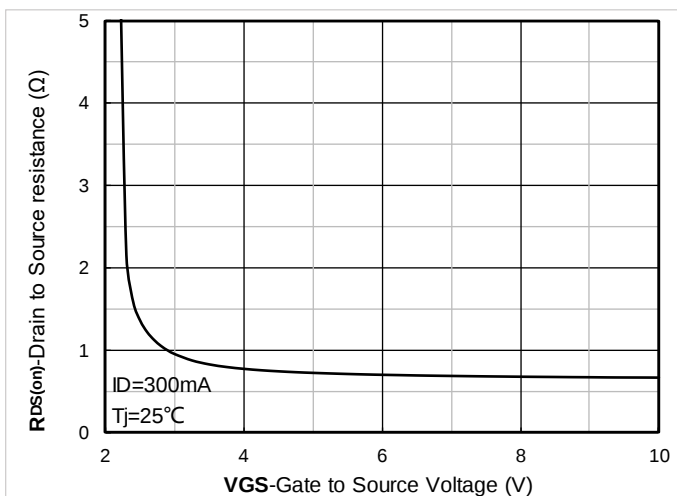


Figure 5. On-Resistance vs Gate to Source Voltage

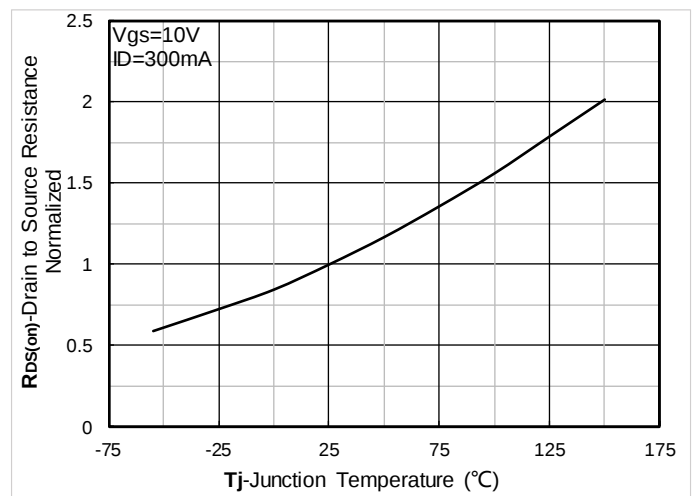


Figure 6. Normalized On-Resistance

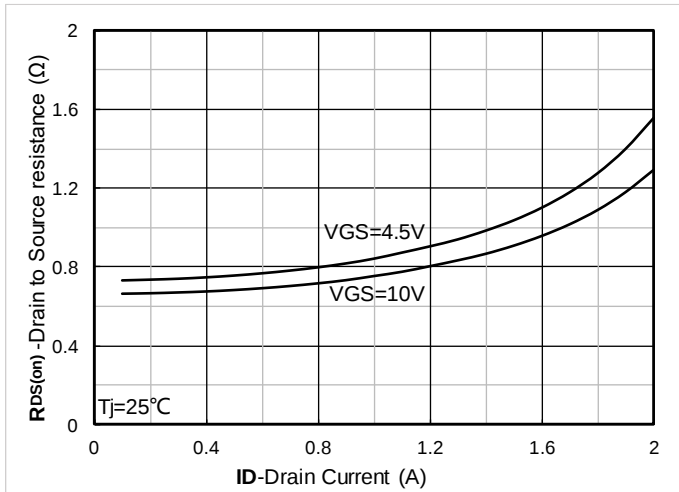


Figure 7. $R_{DS(on)}$ VS Drain Current

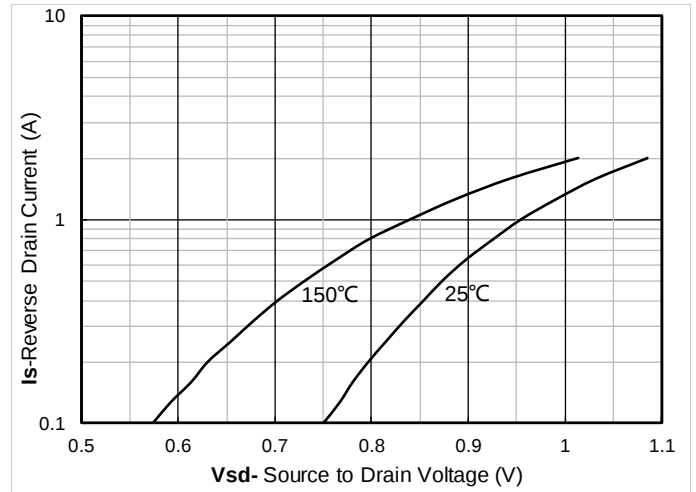


Figure 8. Forward characteristics of reverse diode

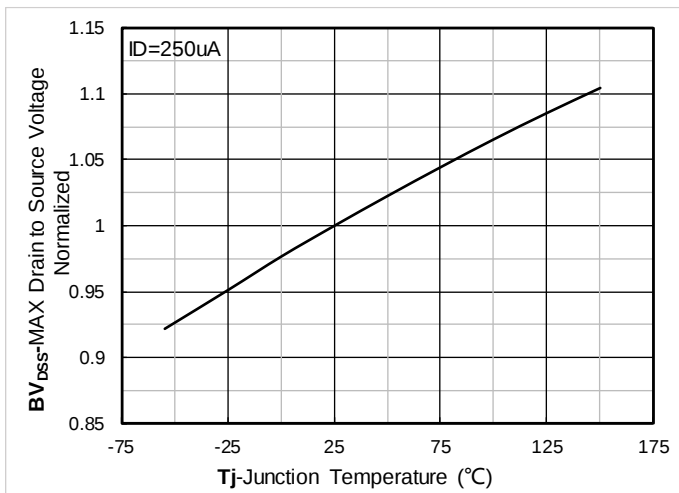


Figure 9. Normalized breakdown voltage

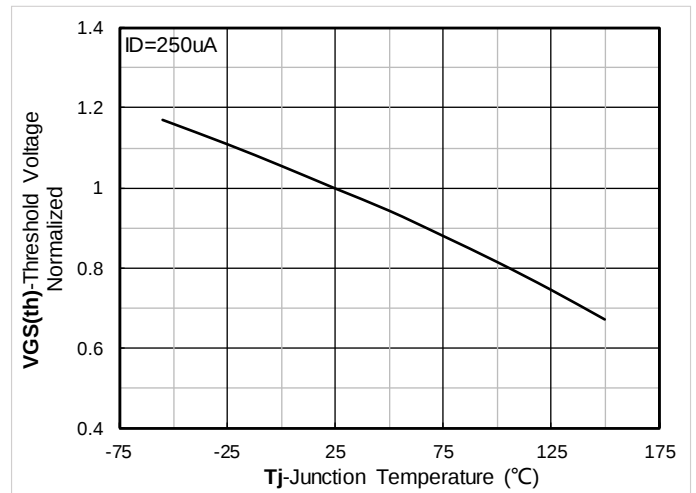


Figure 10. Normalized Threshold voltage

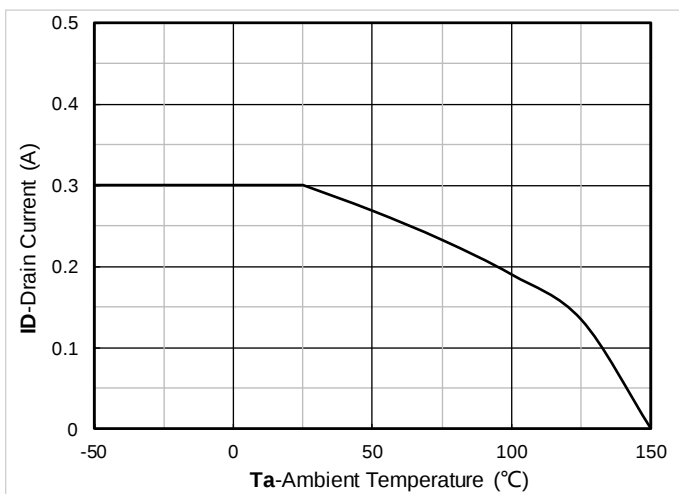


Figure 11. Current dissipation

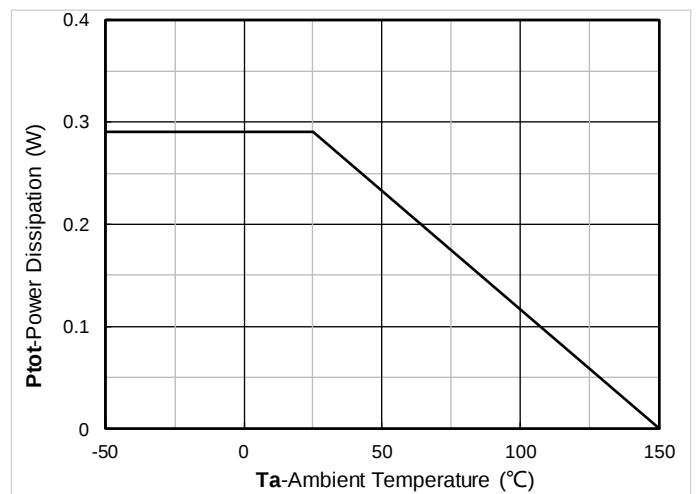


Figure 12. Power dissipation

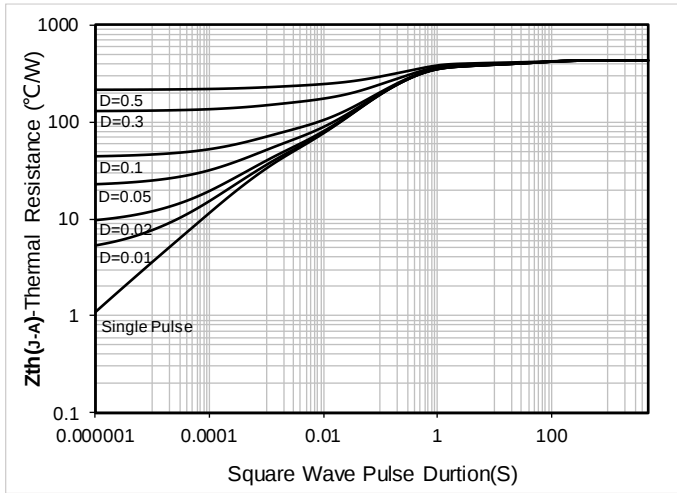


Figure 13. Maximum Transient Thermal Impedance

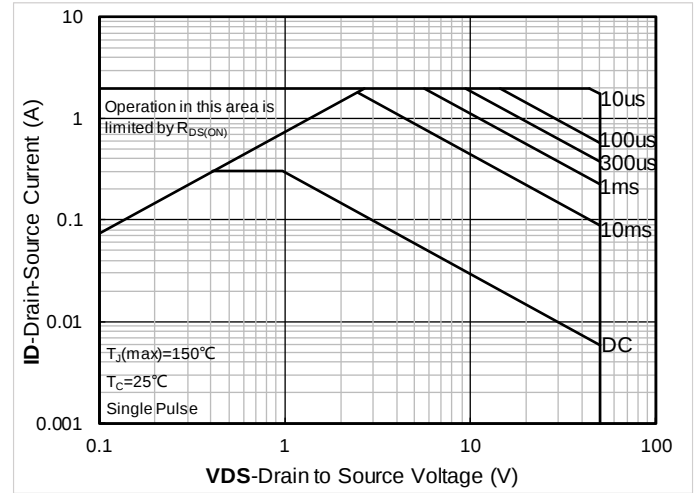


Figure 14. Safe Operation Area

■ Test Circuits & Waveforms

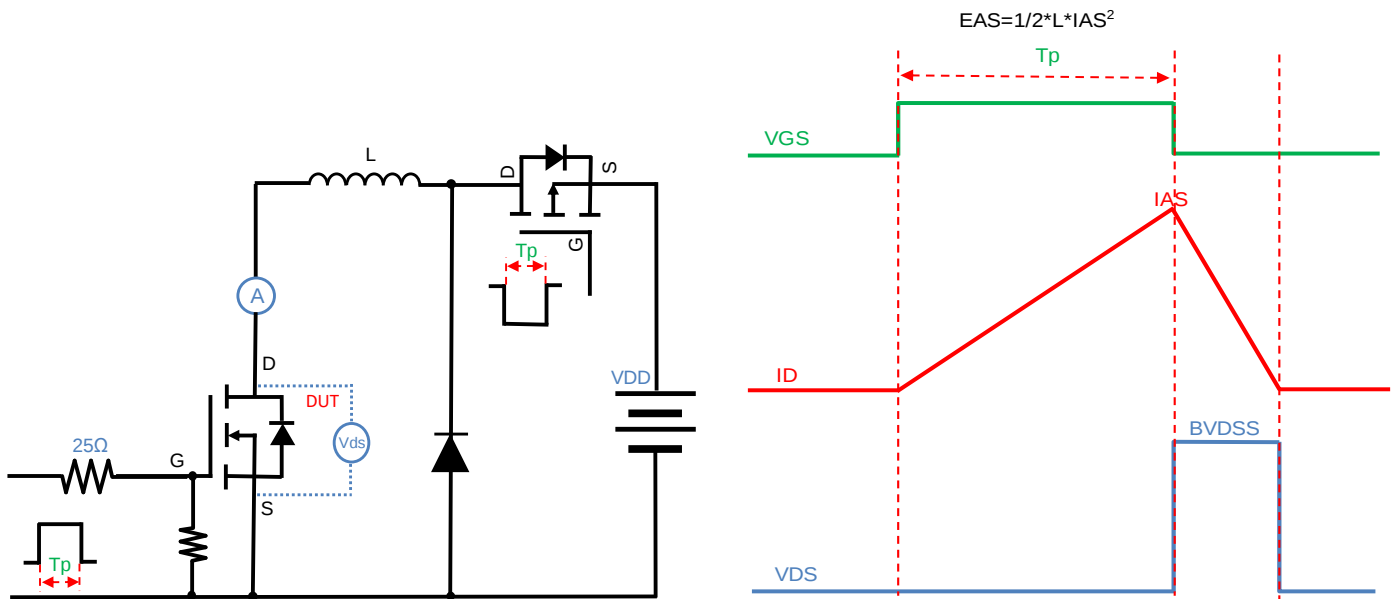


Figure A. Unclamped Inductive Switching (UIS) Test Circuit & Waveform



Figure B. Gate Charge Test Circuit & Waveform



Figure C. Resistive Switching Test Circuit & Waveform

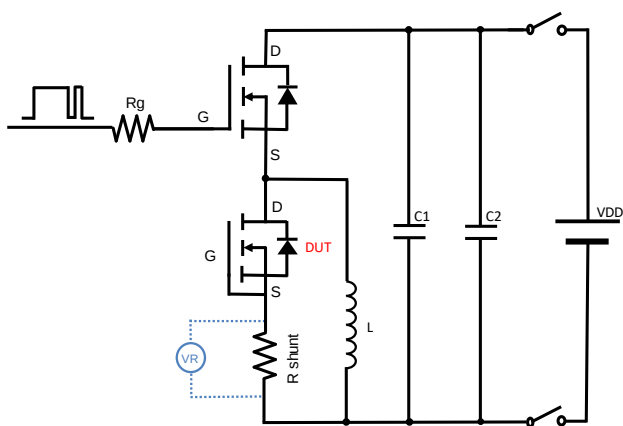
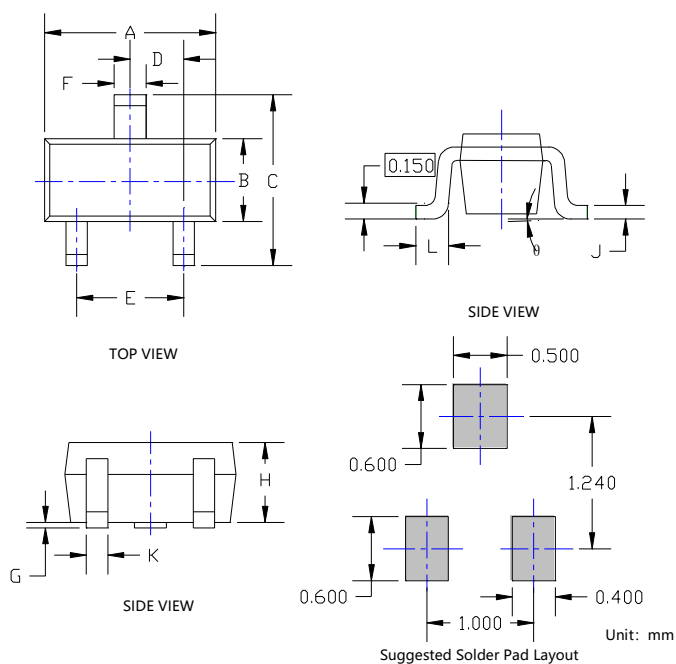


Figure D. Diode Recovery Test Circuit & Waveform

■ SOT-523 Package information



SYMBOL	DIMENSIONS			
	INCHES		Millimeter	
	MIN.	MAX.	MIN.	MAX.
A	0.059	0.067	1.500	1.700
B	0.030	0.033	0.750	0.850
C	0.057	0.069	1.450	1.750
D	0.020TYP		0.500TYP	
E	0.035	0.043	0.900	1.100
F	0.010	0.018	0.250	0.450
G	0.000	0.004	0.000	0.100
H	0.024	0.031	0.600	0.800
J	0.004	0.008	0.100	0.200
K	0.006	0.014	0.150	0.350
L	0.010	0.018	0.260	0.460
θ	0°	8°	0°	8°

NOTE:

1. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS.
2. TOLERANCE 0.1mm UNLESS OTHERWISE SPECIFIED.
3. THE PAD LAYOUT IS FOR REFERENCE PURPOSES ONLY.

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